IRF9230 JANTX2N6806 JANTXV2N6806

REPETITIVE AVALANCHE AND dv/dt RATED HEXFET[®]TRANSISTORS THRU-HOLE (TO-204AA)

Product Summary

ISR HiRe

An Infineon Technologies Company

Part Number	BV _{DSS}	RDS(on)	I _D
IRF9230	-200V	0.80Ω	-6.5A

200V, P-CHANNEL REF: MIL-PRF-19500/562



Description

HEXFET[®] MOSFET technology is the key to IR Hirel advanced line of power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high trans conductance; superior reverse energy and diode recovery dv/dt capability.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.

Features

- Repetitive Avalanche Ratings
- Dynamic dv/dt Rating
- Hermetically Sealed
- Simple Drive Requirements
- ESD Rating: Class 1C per MIL-STD-750, Method 1020

Symbol	Parameter	Value	Units	
$I_{D1} \textcircled{O} V_{GS} = -10V, T_C = 25^{\circ}C$ Continuous Drain Current		-6.5		
$_{D2} @ V_{GS} = -10V, T_{C} = 100^{\circ}C$	Continuous Drain Current	-4.0	А	
I _{DM} @T _C = 25°C	Pulsed Drain Current ①	-26		
P _D @T _C = 25°C	Maximum Power Dissipation	75	W	
	Linear Derating Factor	0.60	W/°C	
V _{GS}	Gate-to-Source Voltage	± 20	V	
E _{AS}	Single Pulse Avalanche Energy ②	181	mJ	
I _{AR}	Avalanche Current ①	-6.5	А	
E _{AR}	Repetitive Avalanche Energy ①	7.5	mJ	
dv/dt	Peak Diode Recovery 3	-5.0	V/ns	
TJ	Operating Junction and		°C	
T _{STG}	Storage Temperature Range	-55 to + 150		
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)		
	Weight	11.5 (Typical)	g	

Absolute Maximum Ratings

For footnotes refer to the page 2.



Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)						
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	-200			V	$V_{GS} = 0V, I_{D} = -1.0mA$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.20		V/°C	Reference to 25°C, $I_D = -1.0$ mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.80	0	V_{GS} = -10V, I_{D2} = -4.0A ④
	Static Drain-to-Source On-Resistance			0.94	Ω	V _{GS} = −10V, I _{D1} = −6.5A ④
V _{GS(th)}	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
I _{DSS}	Zero Gate Voltage Drain Current			-25	μA	V _{DS} = -160V, V _{GS} = 0V
				-250	μΑ	V_{DS} = -160V, V_{GS} = 0V, T_{J} =125°C
I _{GSS}	Gate-to-Source Leakage Forward			-100	nA	V _{GS} = -20V
	Gate-to-Source Leakage Reverse			100		V _{GS} = 20V
Q_{G}	Total Gate Charge			31		I _{D1} = -6.5A
Q_{GS}	Gate-to-Source Charge			7.0	nC	V _{DS} = -100V
Q_{GD}	Gate-to-Drain ('Miller') Charge			17		V _{GS} = -10V
t _{d(on)}	Turn-On Delay Time			50		V _{DD} = -100V
tr	Rise Time			100	ns	I _{D1} = -6.5A
t _{d(off)}	Turn-Off Delay Time			100	115	R _G = 7.5Ω
t _f	Fall Time			80		V _{GS} = -10V
Ls +L _D	Total Inductance		6.1		nЦ	Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/ 0.25 in from package)
C _{iss}	Input Capacitance		700			V _{GS} = 0V
C _{oss}	Output Capacitance		200		pF	V _{DS} = -25V
C _{rss}	Reverse Transfer Capacitance		40			f = 1.0MHz

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

Source-Drain Diode Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current (Body Diode)			-6.5	^	
I _{SM}	Pulsed Source Current (Body Diode) ①			-26	A	
V _{SD}	Diode Forward Voltage			-6.0	V	$T_J = 25^{\circ}C, I_S = -6.5A, V_{GS} = 0V@$
t _{rr}	Reverse Recovery Time			400	ns	$T_{\rm J}$ = 25°C, $I_{\rm F}$ = -6.5A, $V_{\rm DD} \le -50V$
Q _{rr}	Reverse Recovery Charge			4.0	μC	di/dt = -100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{\mbox{\scriptsize S}}\mbox{+} L_{\mbox{\scriptsize D}})$				

Thermal Resistance

Symbol	Parameter	Min.	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case			1.67	°C/W
R _{0JA}	Junction-to-Ambient (Typical socket mount)			30	C/W

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- \odot $~V_{\text{DD}}$ = -50V, starting T_{J} = 25°C, L= 8.6mH, Peak I_L = -6.5A, V_{GS} = -10V.
- $(3 ~~I_{SD}~\leq~-6.5A,~di/dt~\leq~-120A/\mu s,~V_{DD}\leq~-200V,~T_J \leq 150^\circ C.$ Suggested RG =7.5 Ω



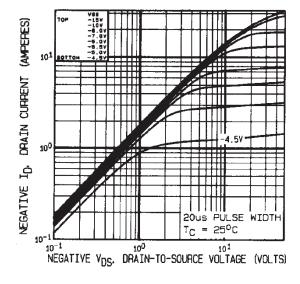


Fig 1. Typical Output Characteristics

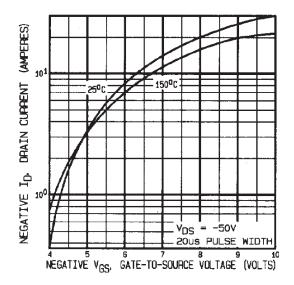


Fig 3. Typical Transfer Characteristics

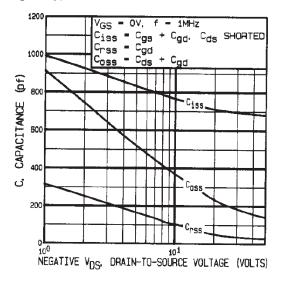


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

IRF9230 JANTX2N6806/JANTXV2N6806

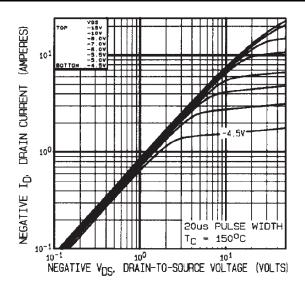


Fig 2. Typical Output Characteristics

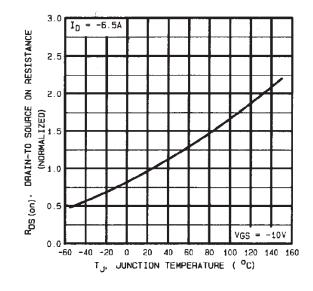
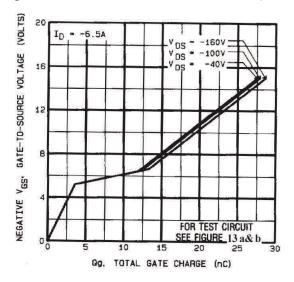
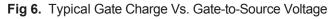


Fig 4. Normalized On-Resistance Vs. Temperature





3



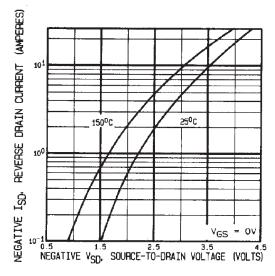


Fig 7. Typical Source-Drain Diode Forward Voltage

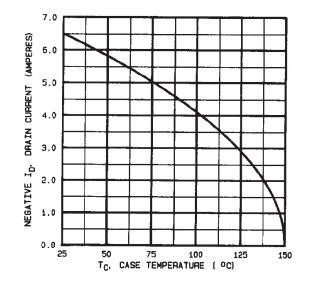


Fig 9. Maximum Drain Current Vs. Case Temperature



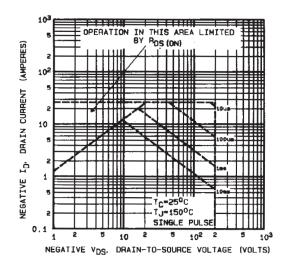


Fig 8. Maximum Safe Operating Area

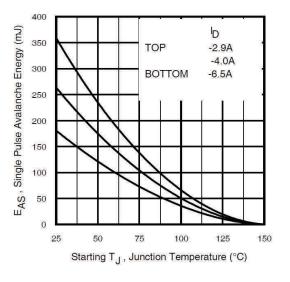


Fig 10. Maximum Avalanche Energy Vs. Drain Current

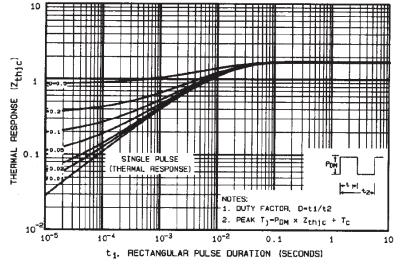


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

4



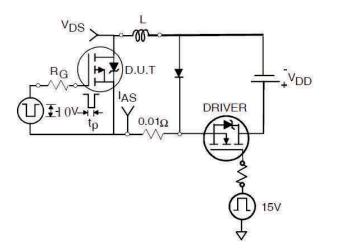
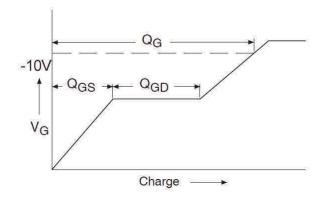
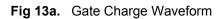


Fig 12a. Unclamped Inductive Test Circuit





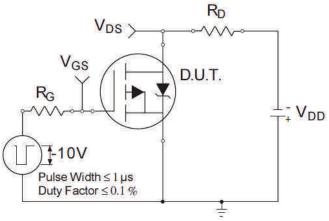
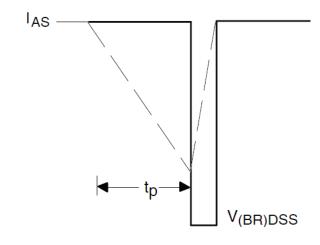
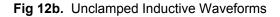


Fig 14a. Switching Time Test Circuit





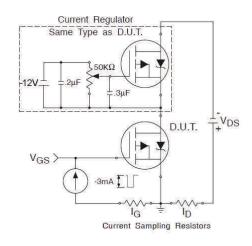
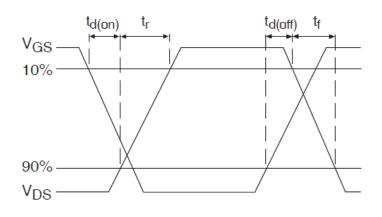
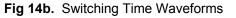


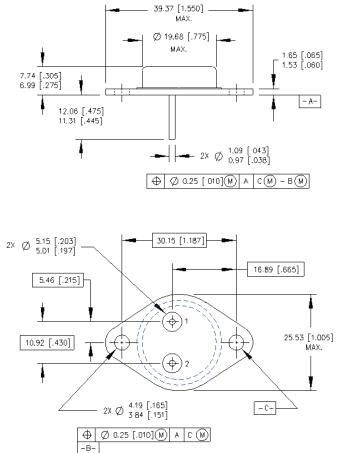
Fig 13b. Gate Charge Test Circuit







Case Outline and Dimensions - TO-204AA (Modified TO-3)



	PIN ASSIGNMENTS	
HEXFET	SCHOTTKY	<u>IGBT</u>
1 - SOURCE 2 - GATE 3 - DRAIN (CASE)	1 - ANODE 1 2 - ANODE 2 3 - COMMON CATHOD (CASE)	1 - GATE 2 - EMITTER 3 - COLLECTOR (CASE)

NOTES:

- 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M 1982 2. CONTROLLING DIMENSION : INCH.
- 2. CONTROLLING DIMENSION . INCH. 3. DIMENSIONS ARE SHOWN IN MILIMETERS [INCHES] 4. OUTLINE CONFORMS TO JEDEC OUTLINE TO -204-AA



www.infineon.com/irhirel

Infineon Technologies Service Center: USA Tel: +1 (866) 951-9519 and International Tel: +49 89 234 65555 Leominster, Massachusetts 01453, USA Tel: +1 (978) 534-5776 San Jose, California 95134, USA Tel: +1 (408) 434-5000 Data and specifications subject to change without notice.



IMPORTANT NOTICE

The information given in this document shall be in no event regarded as guarantee of conditions or characteristic. The data contained herein is a characterization of the component based on internal standards and is intended to demonstrate and provide guidance for typical part performance. It will require further evaluation, qualification and analysis to determine suitability in the application environment to confirm compliance to your system requirements.

With respect to any example hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind including without limitation warranties on non- infringement of intellectual property rights and any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's product and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of any customer's technical departments to evaluate the suitability of the product for the intended applications and the completeness of the product information given in this document with respect to applications.

For further information on the product, technology, delivery terms and conditions and prices, please contact your local sales representative or go to (<u>www.infineon.com/hirel</u>).

WARNING

Due to technical requirements products may contain dangerous substances. For information on the types in question, please contact your nearest Infineon Technologies office.

7